







## 1. Electrical Parameters

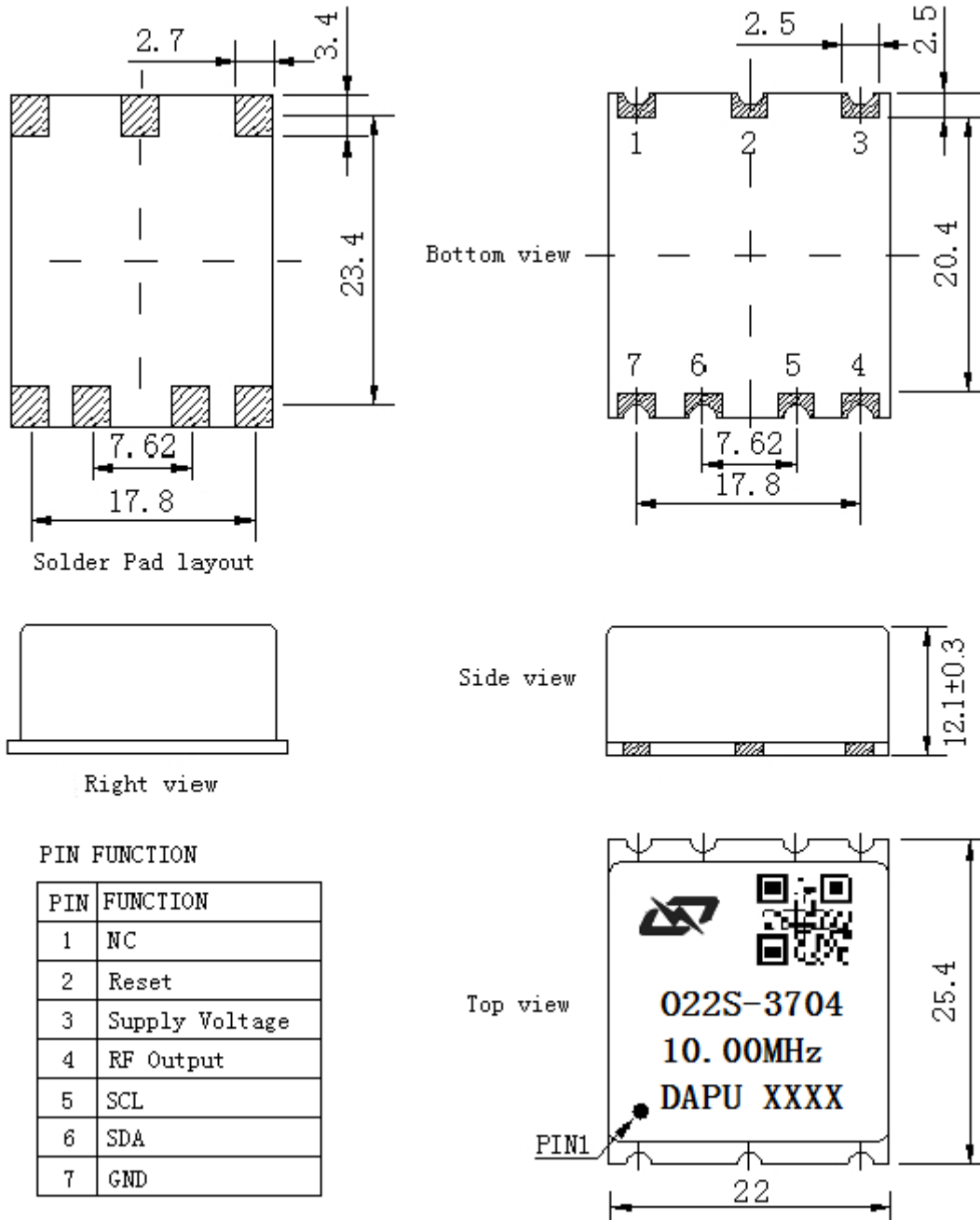
| MODEL: O22S-3704-10.00MHz |   |            |      |      |                  |  |
|---------------------------|---|------------|------|------|------------------|--|
| Item                      | Description   | Parameters |      |      | Unit             | Test Condition   |
|                           |   | Min.       | Typ. | Max. |                  |  |
| Output                    | Frequency   | 10.00      |      |      | MHz              |  |
|                           | Output Waveform   | LVCMOS     |      |      |                  |  |
|                           | Output Low Voltage  |            |      | 0.4  | V                | $V_{cc}=3.3V$ , Load =15pF   |
|                           | Output High Voltage   | 2.4        |      |      | V                | $V_{cc}=3.3V$ , Load =15pF   |
|                           | Duty Cycle  | 45         | 50   | 55   | %                |  |
|                           | Spurious Suppression  |            |      | -90  | dBc              |  |
|                           | Rise/Fall Time  |            |      | 8    | ns               |  |
|                           | Load  | 15         |      |      | pF               |  |
| Frequency Stabilities     | Initial Frequency Tolerance   | -1.0       |      | +1.0 | $\times 10^{-6}$ | After 2 hours and 5 minutes warm up time (after reflow), Measurement referenced to the frequency (before reflow)                               |
|                           | Frequency Stability vs. Operating Temperature Range   | -5.0       |      | +5.0 | $\times 10^{-9}$ | TA varied from -40 to 90°C, $V_{cc}=3.3V$ , and Load = 15pF.Measurement referenced to frequency observed With TA = 25 °C , $V_{cc}=3.3V$ .     |
|                           | Frequency Tolerance after Temperature Compensated vs Operating Temperature Range(at 3rd and 5th Polynomial) | -0.3       |      | +0.3 | $\times 10^{-9}$ | TA varied from -40 to 90°C, $V_{cc}=3.3V$ , and Load = 15 pF.<br>Measurement referenced to frequency observed With TA = 25 °C, $V_{cc}=3.3V$ . |
|                           | Frequency Jump  |            |      | 0.05 | $\times 10^{-9}$ | Continuous testing for 48 hours, temperature Fluctuations< 3 °C ,one sampling/10s.   |
|                           | Hysteresis  |            |      | 0.3  | $\times 10^{-9}$ |  |
|                           | Frequency Stability vs. Supply Voltage  | -0.5       |      | +0.5 | $\times 10^{-9}$ | measurement referenced to frequency observed $T_A=25^\circ C$ , $V_{cc}$ varied from 3.13V to 3.47V, and $O_{Load}=15pF$ .                     |
|                           | Frequency Tolerance vs Load   | -0.5       |      | +0.5 | $\times 10^{-9}$ | 5% load change measurement referenced to frequency observed with $T_A=25^\circ C$ , $V_{cc}=3.3V$ , and $O_{Load}=15pF$ .                      |



|                          |  |  |     |         |   |   |
|--------------------------|--|--|-----|---------|---|---|
|                          | Aging Tolerance day  | -0.6   |     | +0.6    | $\times 10^{-9}$  | After 3 days  |
|                          | Aging Slope Variation (/day)   | -0.4   |     | +0.4    | $\times 10^{-9}$  |   |
|                          | Aging Tolerance 10 Years   | -0.5   |     | +0.5    | $\times 10^{-6}$  |   |
| Power Supply             | Supply Voltage   | 3.13   | 3.3 | 3.47    | V   |   |
|                          | Steady Consumption   |  |     | 400     | mA  | @25°C   |
|                          | Warm up current  |  |     | 1000    | mA  |   |
|                          | Warm-Up Time   |  |     | 5       | minutes   | @25 °C within $\pm 0.02 \times 10^{-6}$ of final frequency with reference after 1 hours on. |
|                          |  |  | 10  | minutes | @25 °C within $\pm 0.01 \times 10^{-6}$ of final frequency with reference after 1 hours on. |   |
| Phase Noise              | Phase Noise  |  |     | -80     | dBc/Hz  | 1Hz   |
|                          |  |  |     | -120    |   | 10Hz  |
|                          |  |  |     | -140    |   | 100Hz   |
|                          |  |  |     | -145    |   | 1KHz  |
|                          |  |  |     | -150    |   | 10KHz   |
|                          |  |  |     | -150    |   | 100KHz  |
| Environmental Conditions | Operating Temperature  | -40  |     | +90     | °C  |   |
|                          | Storage Temperature  | -55  |     | +125    | °C  |   |
|                          | ESD Level  | Human Body Model, class2: 2000V to 4000V; ANSI/ESDA/JEDEC JS-001-2010.   |     |         |   |   |
|                          |  | Machine Model, class B: 200V to 400V; ANSI/ESDA/JEDEC JS-001-2010.   |     |         |   |   |
|                          | Moisture Sensitivity Level   | Level 3.   |     |         |   |   |
|                          | Vibration  | Test Condition: 0.75mm ;acceleration:10g;10Hz~500Hz, one cycle per 30 min, test 2 hour. (3 times for each 3 directions X ,Y , Z), IEC 68-2-06 Test Fc. |     |         |   |   |
| Shock                    | 50g; 11ms; half sine wave (3 times for each 3 directions X ,Y , Z),IEC 68-2-27 Test Ea/Severity 50A. |  |     |         |   |   |
| Full Package Storage     | Relative Humidity (%)  | 20% ~70%   |     |         |   |   |
|                          | Temperature (°C)   | -10~35°C   |     |         |   |   |



## 2. Mechanical Structure (mm)



**Note1:** Tolerance ±0.20mm without mark

**Note2:** The first two xx representative: week  
After two xx representative: year

**Note3:** Referential weight 10g

**Note4:** NC is not connect

**Note5:** The PIN2 function is: Input by low level voltage, the OCXO internal MCU will reset (reset MCU only).



### 3. I<sup>2</sup>C Devices Address

Device name: PIC16F1704

Device supplier: MICROCHIP

Device address: 1110 000

#### Memory map

| Address     | Size bytes | Parameter  | Format                  | Value              |
|-------------|------------|--|-------------------------|--------------------|
| 0000h~0004h | 5          | Vendor ID  | ASCII                   | DP                 |
| 0005h~0024h | 32         | Vendor Product ID  | ASCII                   | O22S-3704-10.00MHz |
| 0025h~0028h | 4          | Nominal frequency in Hertz   | 32-bit unsigned integer | 10000000           |
| 0029h~002Ch | 4          | Device serial number   | 32-bit unsigned integer | 001                |
| 002Dh~0032h | 6          | Date code of manufacture   | ASCII                   | “YYMMDD”           |
| 0033h~003dh | 11         | PxxxxxxYYWW<br>P:Vedor code,<br>xxxxxx: OCXO serial<br>number(Insert a null<br>marker at the end when a<br>digit is left.)<br>YY : Production Year, ex)19 =><br>2019<br>WW : Production Week, ex) 45,<br>45weeks | ASCII                   | “PxxxxxxYYWW”      |
| 003Eh~003Fh | 2          | SAMSUNG Reserved   |                         | 00h                |
| 0040h~0047h | 8          | A <sub>0</sub>   | 64-bit floating point   | 1.33E-01           |
| 0048h~004Fh | 8          | A <sub>1</sub>   | 64-bit floating point   | -5.23E-03          |
| 0050h~0057h | 8          | A <sub>2</sub>   | 64-bit floating point   | 3.77E-05           |
| 0058h~005Fh | 8          | A <sub>3</sub>   | 64-bit floating point   | -9.08E-07          |
| 0060h~0067h | 8          | A <sub>4</sub>   | 64-bit floating point   | 1.99E-10           |
| 0068h~006Fh | 8          | A <sub>5</sub>   | 64-bit floating point   | -1.85E-12          |
| 0070h~0077h | 8          | B <sub>0</sub>   | 64-bit floating point   | -1.02E+02          |
| 0078h~007Fh | 8          | B <sub>1</sub>   | 64-bit floating point   | 7.40E-01           |
| 0080h~0087h | 8          | C <sub>0</sub>   | 64-bit floating point   | 7.40E-01           |
| 0088h~008Fh | 8          | C <sub>1</sub>   | 64-bit floating point   | -5.23E-03          |
| 0090h~0097h | 8          | C <sub>2</sub>   | 64-bit floating point   | 3.77E-05           |
| 0098h~009Fh | 8          | C <sub>3</sub>   | 64-bit floating point   | -9.08E-07          |



|             |    |                                   |                         |     |
|-------------|----|-----------------------------------|-------------------------|-----|
| 00A0h~00BFh | 32 | SAMSUNG Reserved                  |                         | 00h |
| 00C0h~00EFh | 48 | Vendor Reserved                   |                         |     |
| 00F0h~00F1h | 2  | OCXO Temperature 10-bit ADC Value | 16-bit unsigned integer | 528 |
| 00F2h~00FFh | 14 | Vendor Reserved                   |                         |     |

Note1: All numerical values are stored in little endian format

Note 2: SDA, SCL, Reset Input low voltage is 0.3V<sub>cc</sub> Max, Input high voltage is 0.7V<sub>cc</sub> Min.

Note 3: MCU and I2C reset do not affect the output quality and waveform of crystal oscillator signal.

Note4: I2C Clock Speed: 100kbit/s Max.

ADC bit map:

| BIT        | 0             | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 |
|------------|---------------|---|---|---|---|---|---|---|---|---|----|----|----|----|----|----|
| 10 bit ADC | 0x000 - 0x3FF |   |   |   |   |   |   |   |   |   | 0  | 0  | 0  | 0  | 0  | 0  |

#### 4. Temperature measurement and compensation scheme

Temperature compensation formula(five functions):

$$A_5P^5 + A_4P^4 + A_3P^3 + A_2P^2 + A_1P + A_0 = \frac{f(P) - f(P_{ref})}{f(P_{ref})}$$

Temperature compensation formula(three functions):

$$C_3P^3 + C_2P^2 + C_1P + C_0 = \frac{f(P) - f(P_{ref})}{f(P_{ref})}$$

A<sub>x</sub>: Temperature compensation parameters (see register list)

C<sub>x</sub>: Temperature compensation parameters (see register list)

P: This parameter is read by ADC and is related to temperature.

f(P): measured frequency.

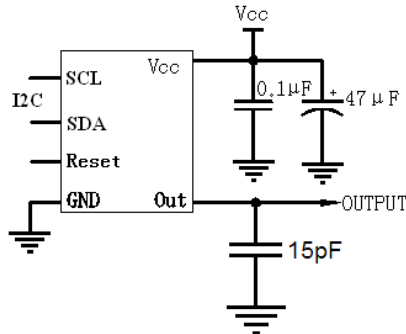
P<sub>ref</sub>: Parameter variables associated with the reference Temperature (25°C)

OCXO Ambient temperature calculation formula:

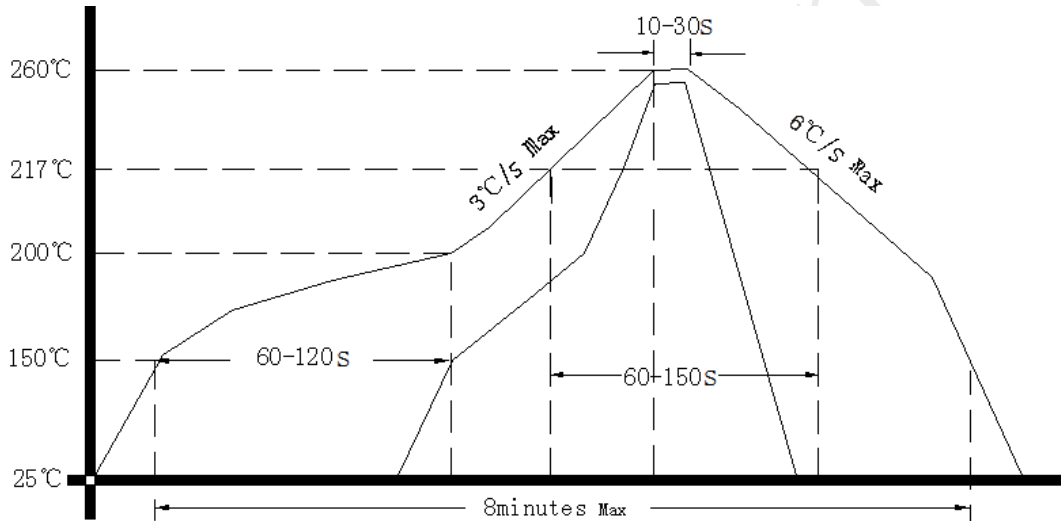
$$B_1P + B_0 = Ta[°C]$$



## 5. Test Circuit



## 6. Reflow Soldering Curve (RoHS)



Note: passing through reflow upside down is not supported

## 7. Package: Tape & Reel (mm)

